

STS17NH3LL

N-channel 30 V - 0.004 Ω - 17 A - SO-8 STripFET™ Power MOSFET for DC-DC conversion

Features

Туре	V _{DSS}	R _{DS(on)}	۱ _D
STS17NH3LL	30V	<0.0057Ω	17A ⁽¹⁾

- 1. This value is rated according to Rthj-pcb
- Optimal R_{DS(on)} x Qg trade-off @ 4.5 V
- Conduction losses reduced
- Improved junction-case thermal resistance
- Low threshold device

Applications

Switching application

Description

This device utilizes the latest advanced design rules of ST's proprietary STripFET[™] technology. This process coupled to unique metallization techniques realizes the most advanced low voltage Power MOSFET in SO-8 ever produced.

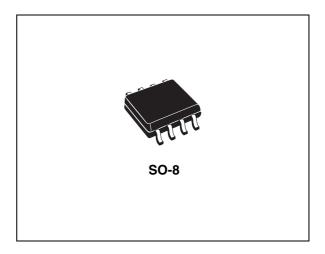


Figure 1. Internal schematic diagram

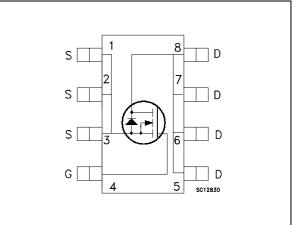


Table 1. Device summary

Order code	Marking	Package	Packaging
STS17NH3LL	17H3LL-	SO-8	Tape & reel

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{GS}	Gate- source voltage	± 16	V
I _D ⁽¹⁾	Drain current (continuous) at $T_C = 25^{\circ}C$	17	Α
I _D	Drain current (continuous) at $T_C = 100^{\circ}C$	10.6	А
I _{DM} ⁽²⁾	Drain current (pulsed)	68	Α
P _{tot} ⁽¹⁾	Total dissipation at $T_{C} = 25^{\circ}C$	2.7	W
T _{stg}	Storage temperature	-55 to 150	°C
Tj	Operating junction temperature	-55 10 150	U

1. This value is rated according to Rthj-pcb

2. Pulse width limited by safe operating area

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
Rthj-pcb ⁽¹⁾	Thermal resistance junction-ambient max	47	°C/W

1. When mounted on 1inch² FR-4 board, 2oz of Cu and t< 10sec

Table 4.Avalanche data

Symbol	Parameter	Value	Unit
I _{AV}	Not-repetitive avalanche current	7.5	А
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, Id=I _{AV})	150	mJ

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} = Max rating @125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 16 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10$ V, $I_D = 8.5$ A $V_{GS} = 4.5$ V, $I_D = 8.5$ A		0.004 0.005	0.0057 0.0075	Ω Ω

Table 5. On/off states

Table 6. Dynamic

	•					
Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} =25 V, f=1 MHz V_{GS} = 0		1810 565 41		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} =15 V, I _D =17 A V _{GS} =4.5 V <i>(see Figure 14)</i>		18 4.8 5.3	24	nC nC nC
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	0.5	1.5	3	Ω



	•••••••					
Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
t _{d(on)} t _r	Turn-on delay time Rise time			8 65		ns ns
t _{d(off)} t _f	Turn-off delay time Fall time	$\begin{split} V_{DD} &= 15 \text{ V}, \text{ I}_{D} = 8.5 \text{ A} \\ \text{R}_{G} &= 4.7 \ \Omega, \ \text{V}_{\text{GS}} = 10 \text{ V} \\ (\text{see Figure 16}) \end{split}$		38 20		ns ns

Table 7.Switching times

Table 8.Source drain diode

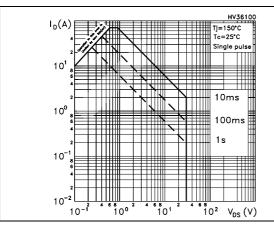
Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD} I _{SDM}	Source-drain current Source-drain current (pulsed)				17 68	A A
V _{SD} ⁽¹⁾	Forward on voltage	I _{SD} = 17 A, V _{GS} = 0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 17 \text{ A},$ di/dt = 100 A/µs $V_{DD} = 15 \text{ V}, \text{ T}_{j} = 25^{\circ}\text{C}$ (see Figure 15)		22 32 1.9		ns nC A

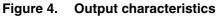
1. Pulsed: pulse duration=300µs, duty cycle 1.5%



Electrical characteristics (curves) 2.1

Figure 2. Safe operating area





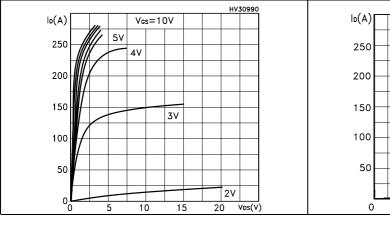
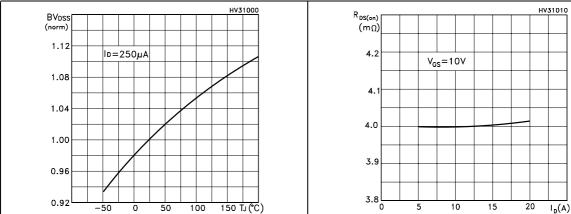


Figure 6. Normalized B_{VDSS} vs temperature





10⁻²

Thermal impedance

Figure 3.

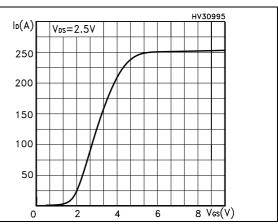
к

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10⁻²

 $\delta = 0.5$

0.2 0.



0.05

0.01

10⁰

SINGLE PULSE

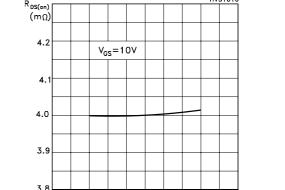
10⁻¹

 $0.02 || Z_{\text{thj-pcb}} = k R_{\text{thj-pcb}}$

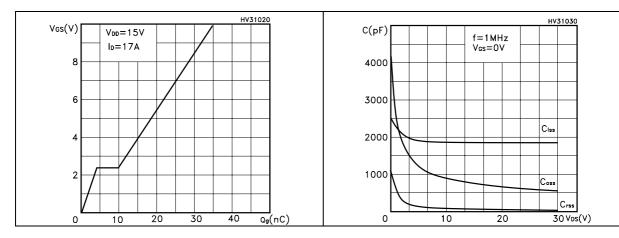
 $\delta = t_p / \tau$ R_{thj-pcb}=60°C/W

10¹ tp (s)

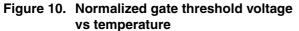
Figure 7. Static drain-source on resistance

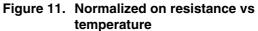


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Gate charge vs gate-source voltage Figure 9. **Capacitance variations** Figure 8.





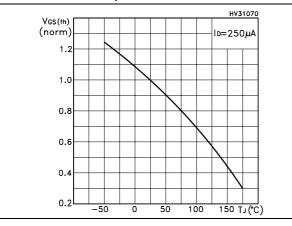
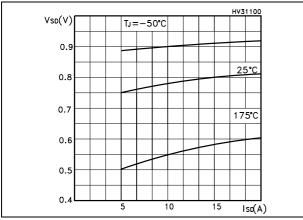
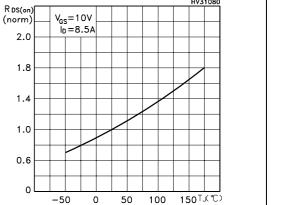


Figure 12. Source-drain diode forward characteristics





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3 Test circuit

Figure 13. Switching times test circuit for resistive load

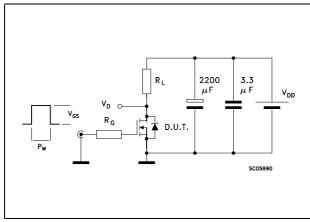
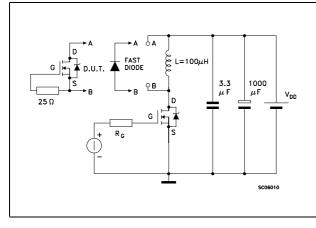
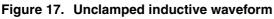


Figure 15. Test circuit for inductive load switching and diode recovery times





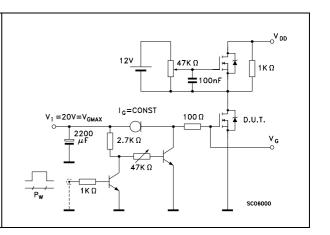
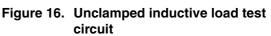
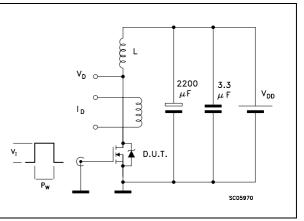
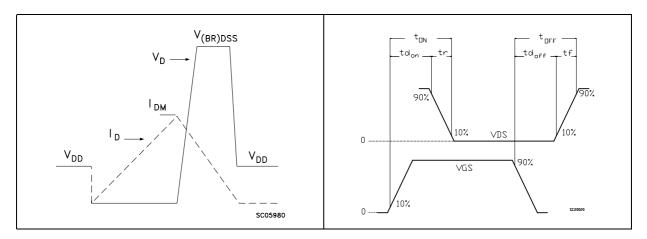


Figure 14. Gate charge test circuit









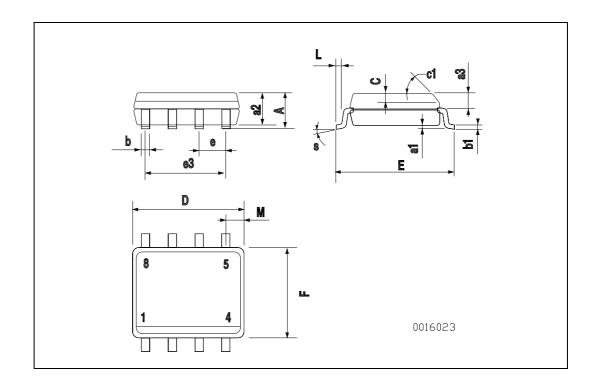
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com*



DIM.		mm.			inch	
DIN.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1		•	45	(typ.)	•	
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023

SO-8 MECHANICAL DATA



5 Revision history

Table 9.Document revision history

Date	Revision	Changes
01-Aug-2006	1	First release
09-Jan-2007	2	Complete version
12-Dec-2007	3	Inserted new Table 4: Avalanche data



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